

Application/Control No.	Applicant(s)/Patent under Reexamination
10/657,107	SASA ET AL.
Examiner	Art Unit
Alex Liew	2624

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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
382/141-152, 167, 274 limited to text search	1/12/2007	AL		
382/141-152, 167, 274 limited to text search	8/7/2007	AL		
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